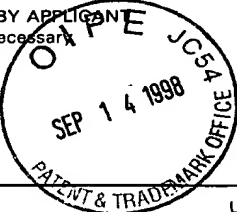


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U. S. PATENT DOCUMENTS							
EXAMINER		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>Ch</i>	AA	4,452,682	06/05/84	Takata, et al.			
<i>Ch</i>	AB	4,568,444	02/04/86	Nakamura, et al.			
<i>Ch</i>	AC	H201	01/06/87	Yager			
<i>Ch</i>	AD	4,777,019	10/11/88	Dandekar			
<i>Ch</i>	AE	4,908,112	03/13/90	Pace			
<i>Ch</i>	AF	4,981,572	01/01/91	Easmunt, et al.			
<i>Ch</i>	AG	4,983,510	01/08/91	Lardinois, et al.			
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<i>Ch</i>	AI	5,156,810	10/20/92	Ribi			
<i>Ch</i>	AJ	5,192,507	03/09/93	Taylor, et al.			
<i>Ch</i>	AK	5,281,539	01/25/94	Schramm			

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	AL						
	AM						
	AN						
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<i>Ch</i>	AQ	D.M. Kolb, R. Ullmann, T. Will, "Nanofabrication of Small Copper Clusters on Gold (111) Electrodes by a Scanning Tunneling Microscope". SCIENCE Magazine, Vol. 275, February 21, 1997, Pages 1097-1099
<i>Ch</i>	AR	Leo Kouwenhoven, "Single-Molecule Transistors". SCIENCE Magazine, Vol. 275, March 28, 1997, Pages 1897-1898
	AS	

EXAMINER <i>Alto Koynerala</i>	DATE CONSIDERED <i>6/16/99</i>
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<i>C.N</i>	BA	5,310,469	05/10/94	Cunningham, et al.			
<i>C.N</i>	BB	5,328,847	07/12/94	Case, et al.			
<i>C.N</i>	BC	5,332,479	07/26/94	Uenoyama, et al.			
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<i>C.N</i>	BE	5,395,587	03/07/95	Brigham-Burke, et al.			
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	BP						
	BQ						
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	BR						
	BS						
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